

# Neutron Optics for focussing and imaging

## WP 5, DK-CH

### (work in progress since September)

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NEXMAP

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SPALLATION  
SOURCE



DANCHIP

# Background: X-rays

**X-rays:** A. Snigirev *et al.* CRL for X-rays: *Nature* **384**, 49 - 51 (1996).

## *Status:*

Synchrotrons: Most used optics for ESRF !  
Transmission X-ray Microscopy

## *Advantages:*

- Cheap
- Very adaptable: wide energy range and wide range of focal spots
- Highly reproducible: Can be inserted and removed rapidly
- Supports various types of microscopy

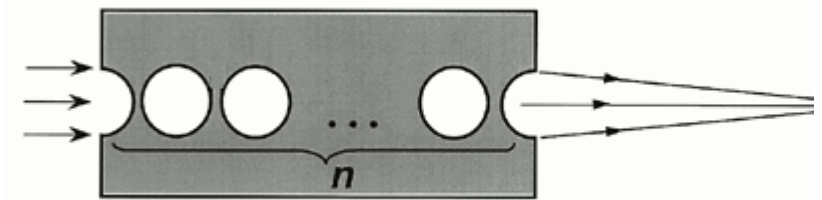
**Neutrons:** M.R. Eskildsen *et al.* CRL for neutrons: *Nature* **391**, 563-566 (1998)

## *Disadvantages*

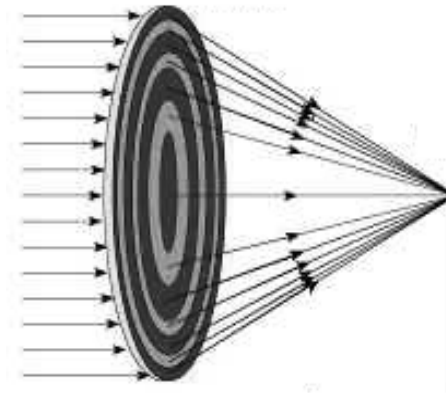
- Less efficient
- Compatibility with time-of-flight?

# Existing lens technology

1. Refractive lenses  
Compound refractive lens



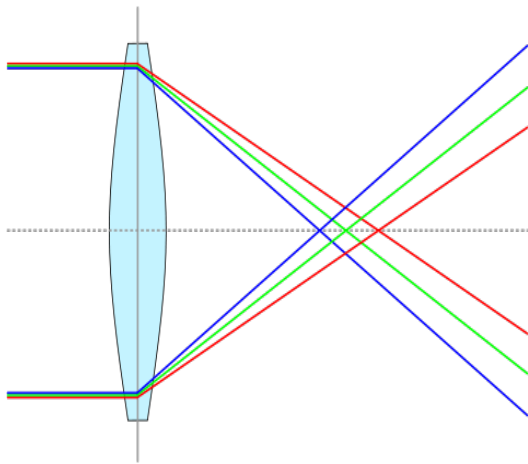
2. Diffractive lenses  
(Fresnel) zone plate



3. Reflective lenses  
Bent supermirror lens

## Extension to TOF, pink beam, white beam:

*Chromatic aberration:*



$$\text{CRL: } \Delta f / f = -2 \Delta \lambda / \lambda$$

$$\text{ZP: } \Delta f / f = -\Delta \lambda / \lambda$$

Mono. synchrotron X-rays:  $\Delta \lambda / \lambda \approx 0.001$

Mono. (e.g. SANS) neutrons:  $\Delta \lambda / \lambda \approx 0.1$



Variations of order  $\Delta \lambda / \lambda$

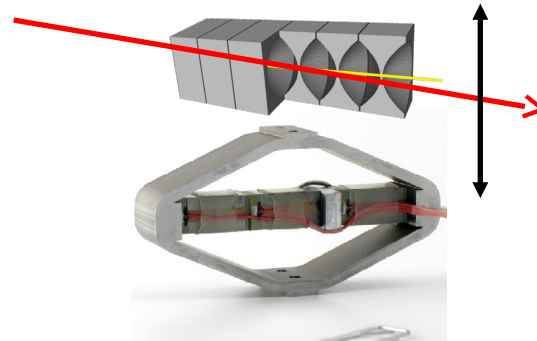
Visible light: Materials with different dispersion are combined

*Not possible for neutrons!*

# Extension to TOF, pink beam, white beam:

Three solutions investigated:

## 1. Mechanical translocator



Piezo: CEDRAT Tech.  
Range: ~1 mm  
Time: ~2 ms

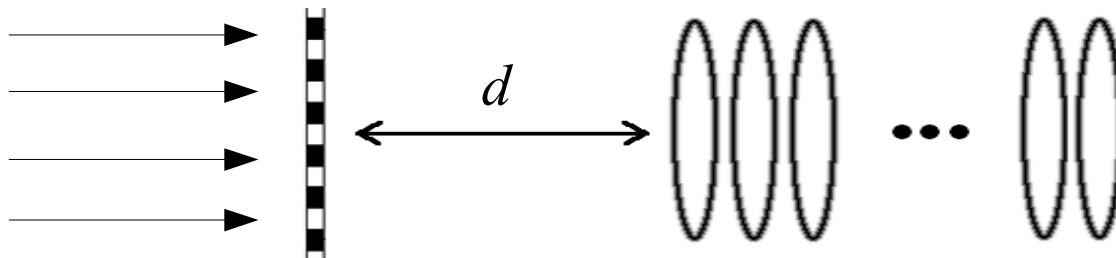
## 2. Magnetic translocator

Make lenses of ferrite: material for fast switching

➡ Polarization at the same time\*

## Extension to TOF, pink beam, white beam:

3. (Passive) combination of ZP and CRL:



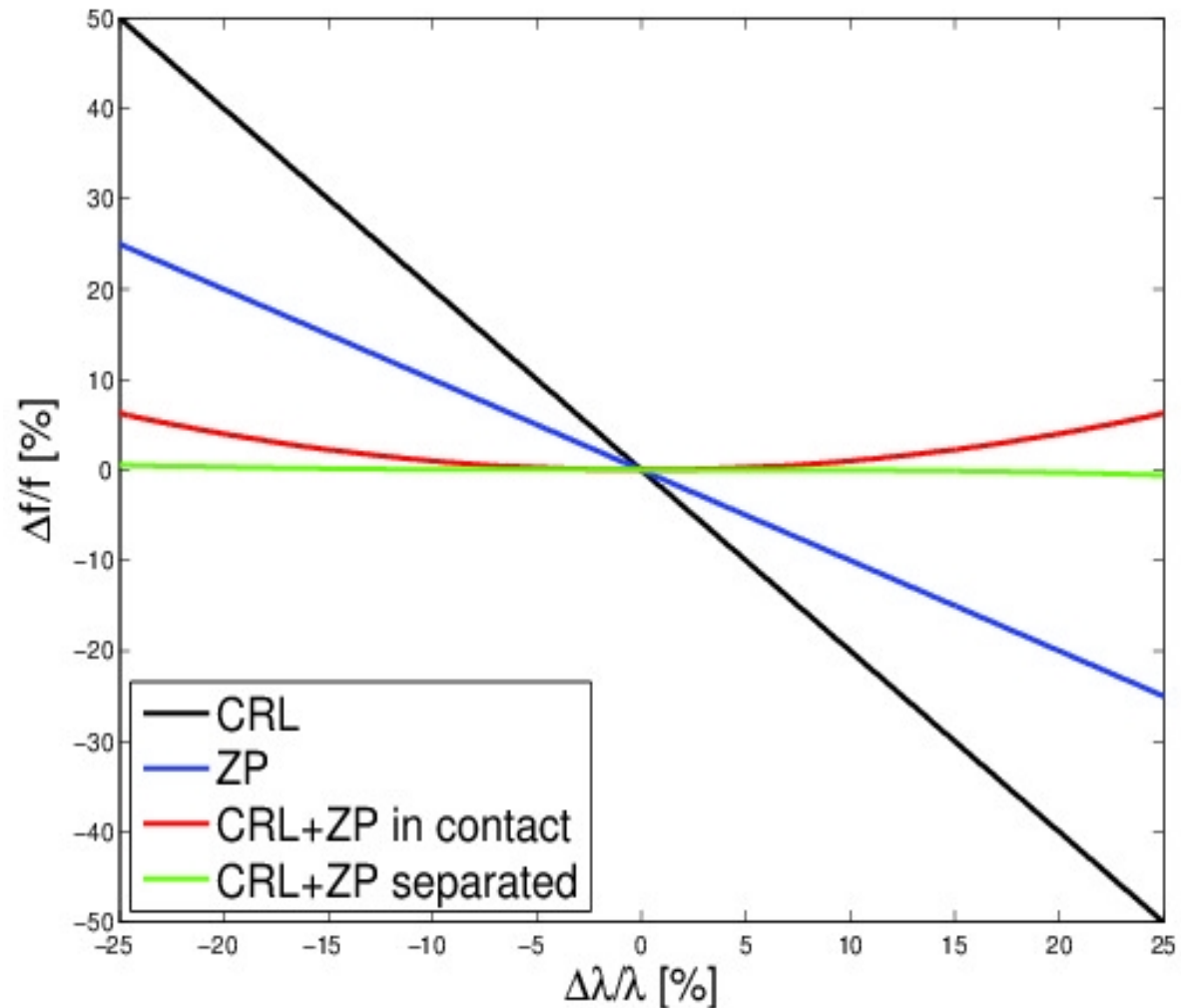
ZP focusses, CRL defocusses

$$d=0 \quad \rightarrow \quad \frac{\Delta f}{f} = \left( \frac{\Delta \lambda}{\lambda} \right)^2$$

$$d>0 \quad \rightarrow \quad \frac{\Delta f}{f} = \frac{-3}{8} \left( \frac{\Delta \lambda}{\lambda} \right)^3$$

## Extension to TOF, pink beam, white beam:

- Chromatic spread for CRL and ZP is substantial
- A CRL and ZP in contact is much better
- A CRL and a ZP distanced is even better



# Experimental investigation of CRL + ZP combination:

is being pursued (at BOA beamline at SINQ)

## Production/purchase of CRL:

**Table 1 Candidate elements for CRLs**

Element/isotope	$b_c/\sigma_a$ ( $\text{fm}^{-1}$ )
O	310
C	19
• Be†	10
Pb*	8.0
• F†	5.8
Zr*	5.3
Pb*	3.1
Bi†	2.5
H*†	2.1
Zr*	1.6
• Mg†	0.86
Mo*	0.85
Mo*	0.68
Sr*	0.43
N*†	0.34
Tl*†	0.24

Be:

- Used for X-rays
- A. Snigirev?

MgF2:

- Used for light
- Commercially available

## Production of ZP:

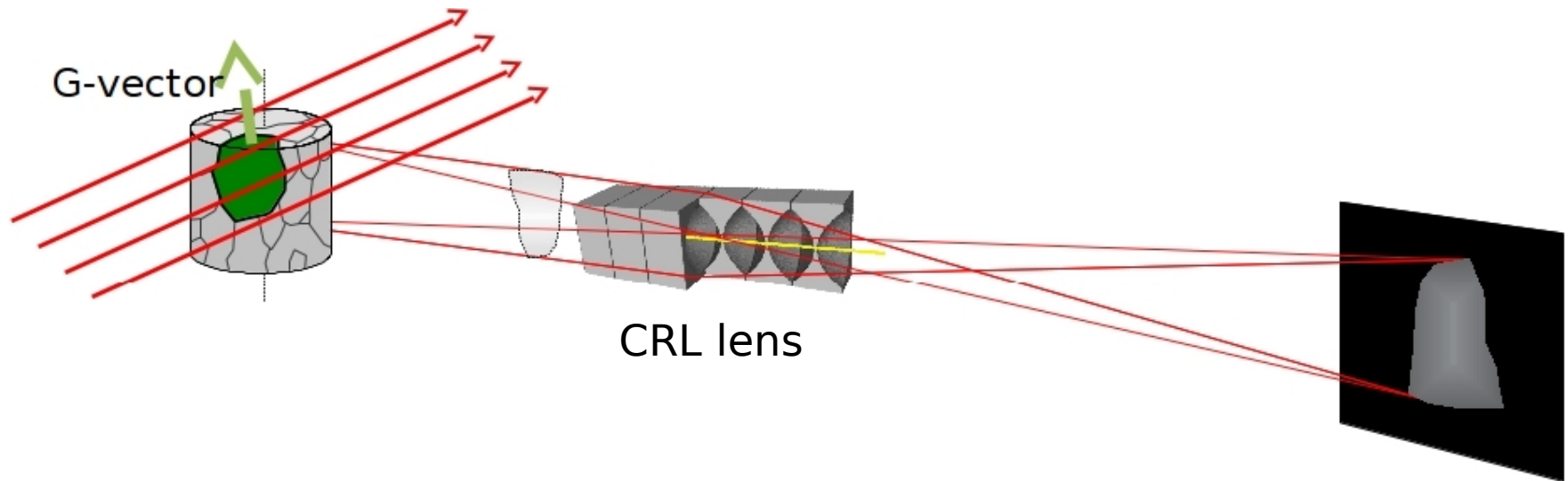
- Lithographic process
- Ni on Si is excellent
- In talks with DANCHIP



Modified from M.R. Eskildsen *et al.*  
Nature **391**, 563-566 (1998)



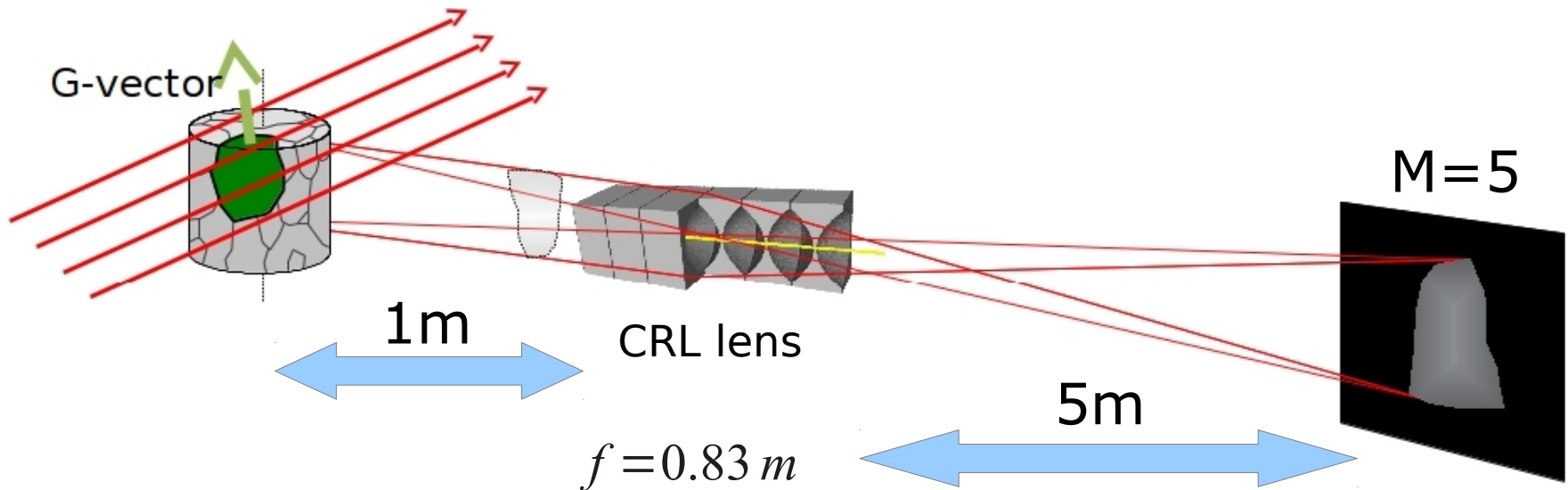
## Example: neutron dark field microscope



- Lenses work best at long wavelengths
- Flux is highest at short wavelengths

Compromise:  $2\theta \approx 160^\circ$

# Example: neutron dark field microscope

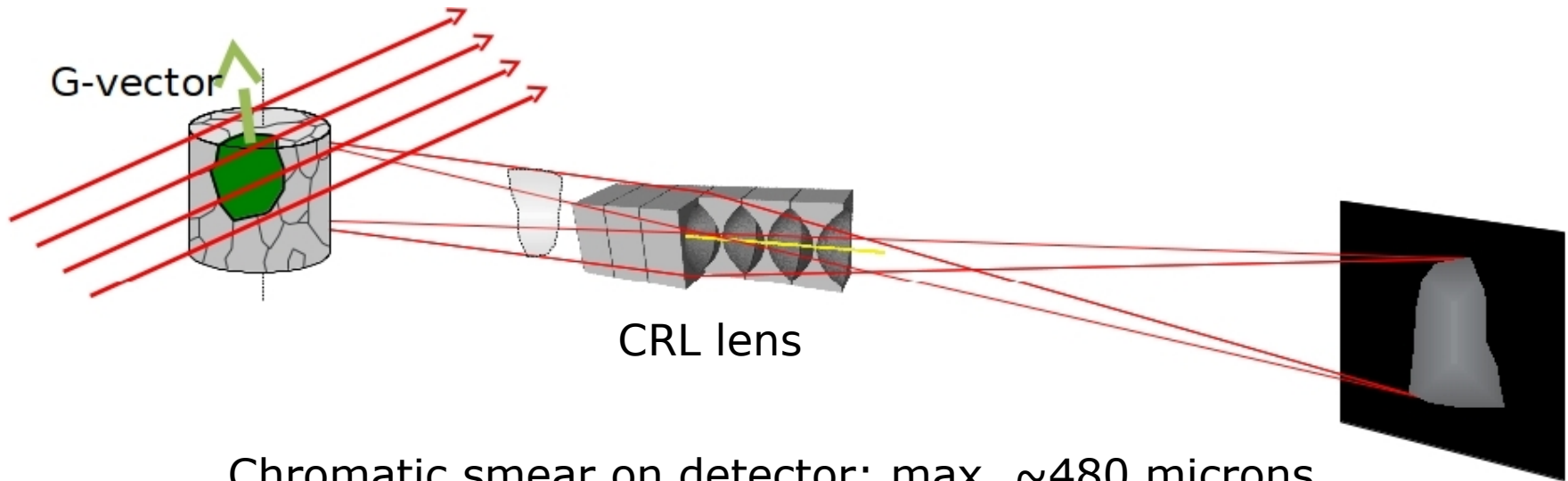


bcc iron,  $a=2.87\text{\AA}$ ,  $d=100$  microns

$\lambda=5.5\text{\AA}$  and  $\Delta\lambda/\lambda\approx 0.01$   $\Rightarrow \Phi\approx 4.4\text{ s}^{-1}$

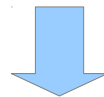
Be lenses,  $d=0.8$  cm  $\Rightarrow N = 96$

# Example: neutron dark field microscope



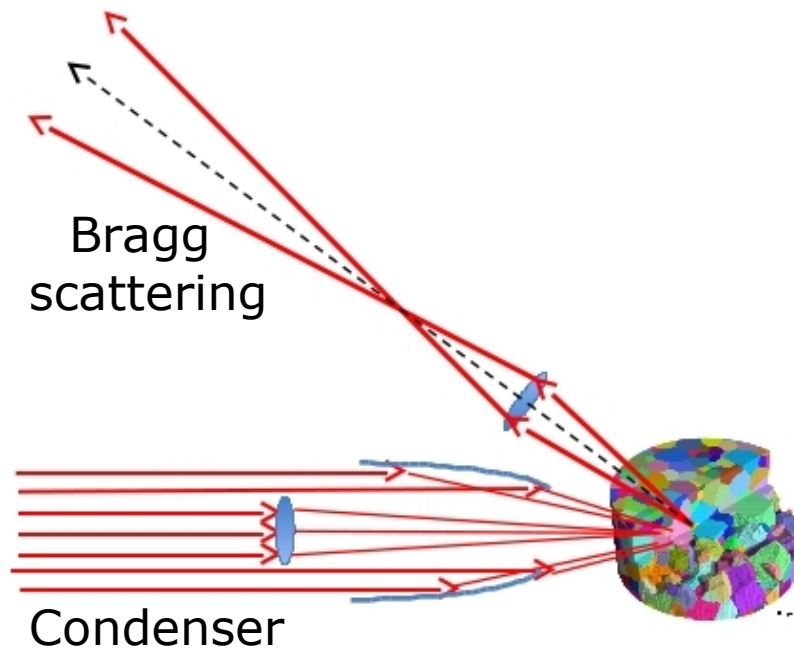
Chromatic smear on detector: max.  $\sim 480$  microns  
 $=$  in sample space: max.  $\sim 100$  microns

Could be reduced / eliminated by an achromatic lens

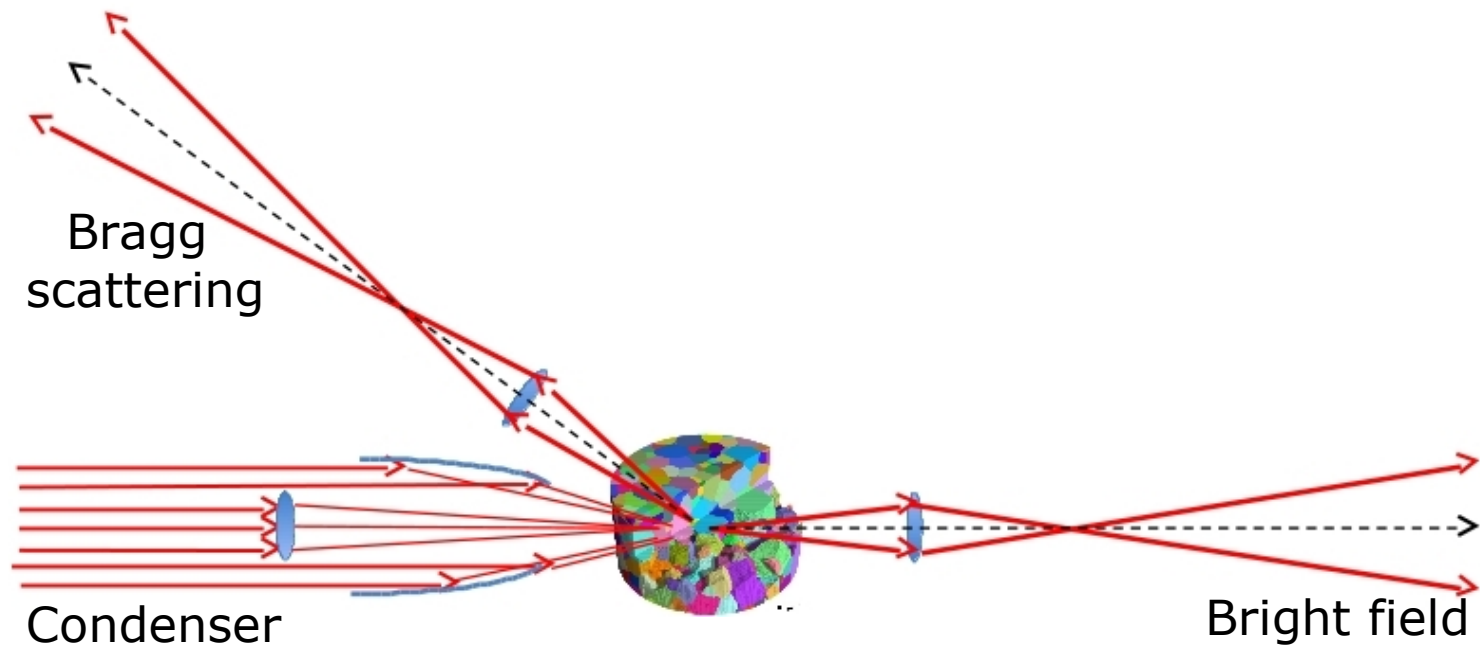


Crystallography, strain, etc. with very high resolution  
 (This is work in progress!)

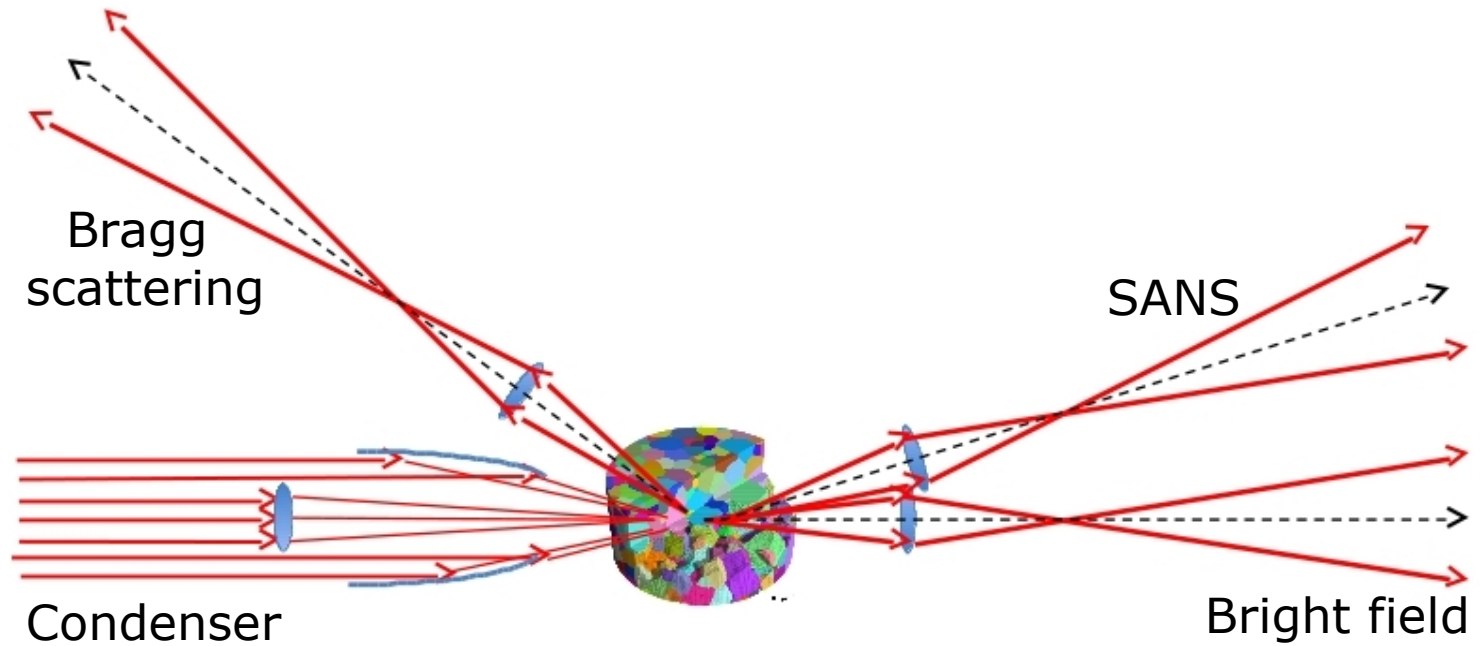
# Neutron microscopy



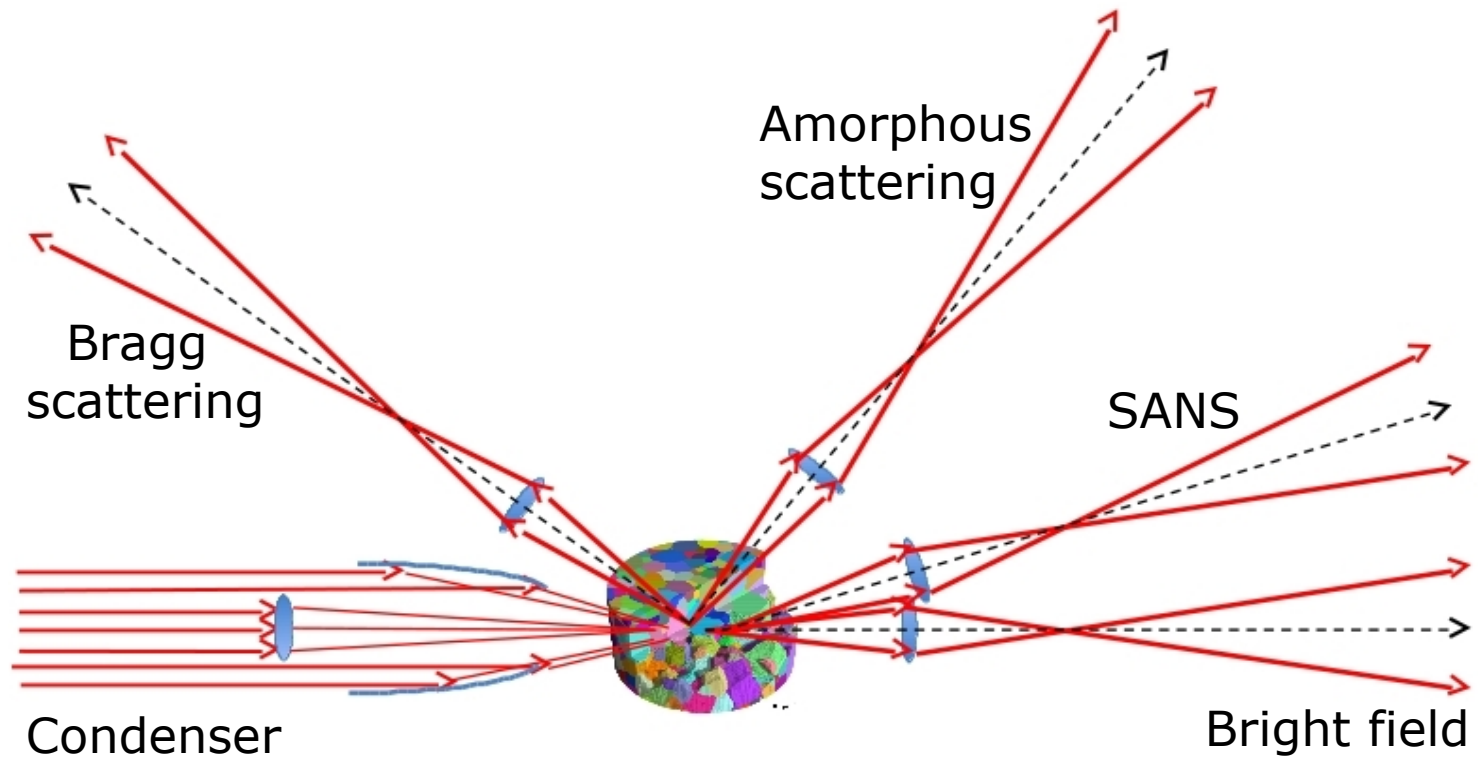
# Neutron microscopy



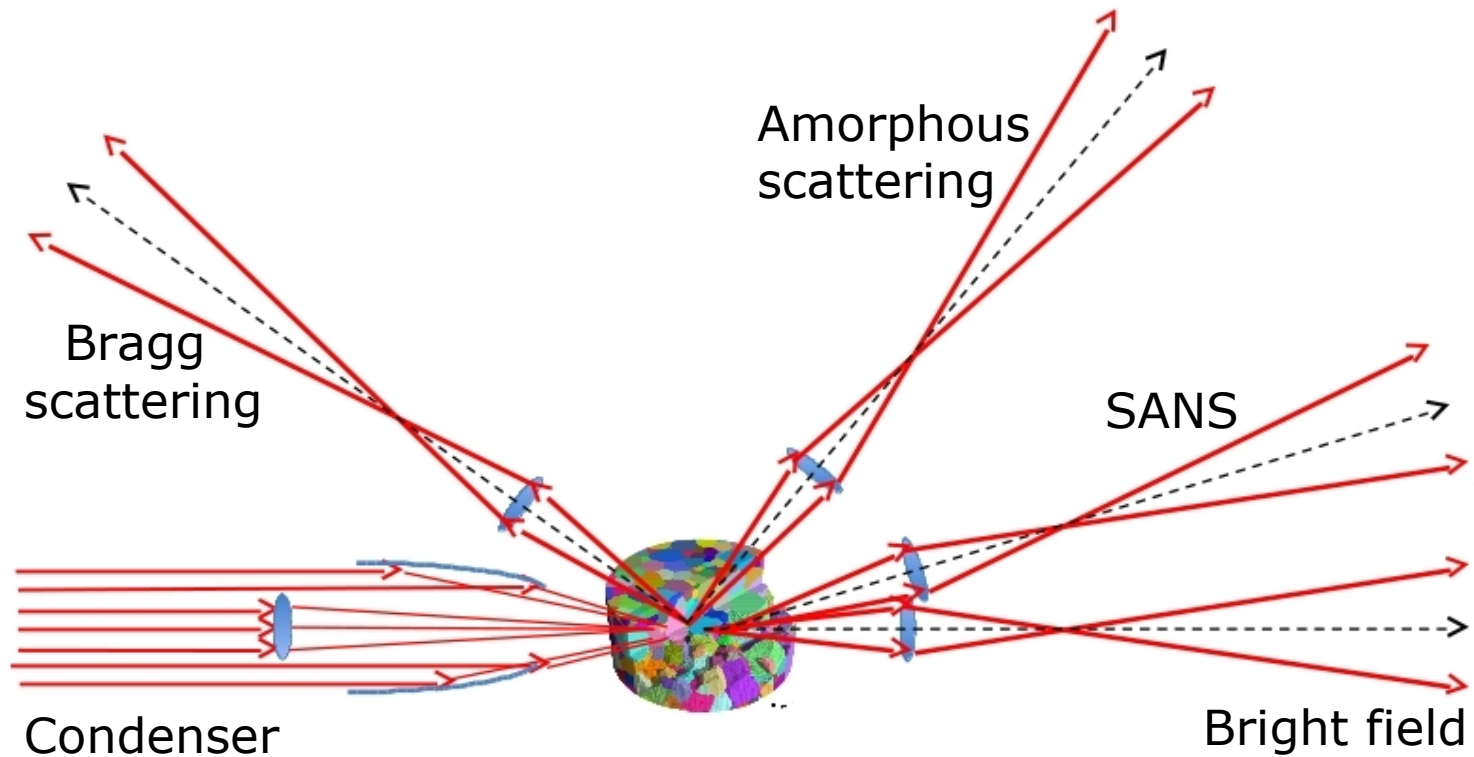
# Neutron microscopy



# Neutron microscopy



# Neutron microscopy



$4\pi$  coverage with objectives →  
 Microscopy in all of rec. space